

Notice of References Cited

Application/Control No.

10/002,519

Applicant(s)/Patent Under
Reexamination
FUJIWARA ET AL.

Examiner

Kim Nguyen

Art Unit

3713

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,283,861 B1	09-2001	Kawai et al.	463/43
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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